DATA SHEET



MOS FIELD EFFECT TRANSISTOR

NP40N055CLE,NP40N055DLE,NP40N055ELE,NP40N055KLE

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance
- $R_{DS(on)1} = 23 \text{ m}\Omega \text{ MAX. } (V_{GS} = 10 \text{ V}, \text{ Id} = 20 \text{ A})$ $R_{DS(on)2} = 28 \text{ m}\Omega \text{ MAX. } (V_{GS} = 5.0 \text{ V}, \text{ Id} = 20 \text{ A})$
- RDS(on)2 = 20 IIIS2 IVIAA. (VGS = 5.0 V, ID = 20)
- Low Ciss: Ciss = 1300 pF TYP.
- Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	55	V
Gate to Source Voltage ($V_{DS} = 0 V$)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±40	А
Drain Current (pulse) Note1	D(pulse)	±100	А
Total Power Dissipation ($T_A = 25^{\circ}C$)	Рт	1.8	W
Total Power Dissipation ($Tc = 25^{\circ}C$)	Рт	66	W
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	–55 to +175	°C
Single Avalanche Current Note2	las	29/21/8	А
Single Avalanche Energy Note2	Eas	0.8/44/64	mJ

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = 28 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V (see Figure 4.)

THERMAL RESISTANCE

Channel to Case Thermal Resistance	Rth(ch-C)	2.27	°C/W
Channel to Ambient Thermal Resistance	Rth(ch-A)	83.3	°C/W

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	PART NUMBER PACKAGE		
	NP40N055CLE	TO-220AB	
	NP40N055DLE	TO-262	
	NP40N055ELE	TO-263 (MP-25ZJ)	
★	NP40N055KLE	TO-263 (MP-25ZK)	

(TO-220AB)



(TO-262)



(TO-263)

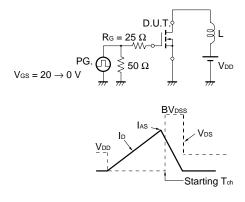


The mark \star shows major revised points.

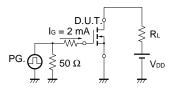
ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	Vds = 55 V, Vgs = 0 V			10	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.5	2.0	2.5	V
Forward Transfer Admittance	y _{fs}	Vds = 10 V, Id = 20 A	8	18		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, Id = 20 A		18	23	mΩ
	RDS(on)2	Vgs = 5.0 V, Id = 20 A		21	28	mΩ
	RDS(on)3	Vgs = 4.5 V, Id = 20 A		24	32	mΩ
Input Capacitance	Ciss	V _{DS} = 25 V		1300	1950	pF
Output Capacitance	Coss	$V_{GS} = 0 V$		190	280	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		92	170	pF
Turn-on Delay Time	td(on)	$V_{DD} = 28 V, I_D = 20 A$		14	32	ns
Rise Time	tr	Vgs = 10 V		8.4	21	ns
Turn-off Delay Time	td(off)	Rg = 1 Ω		39	78	ns
Fall Time	tr			7.4	19	ns
Total Gate Charge 1	Q _{G1}	$V_{DD} = 44 V, V_{GS} = 10 V, I_D = 40 A$		27	41	nC
Total Gate Charge 2	Q _{G2}	V _{DD} = 44 V		15	23	nC
Gate to Source Charge	QGS	Vgs = 5.0 V		5		nC
Gate to Drain Charge	Qgd	ID = 40 A		8		nC
Body Diode Forward Voltage	VF(S-D)	IF = 40 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 40 A, VGS = 0 V		40		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		50		nC

TEST CIRCUIT 1 AVALANCHE CAPABILITY

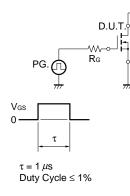


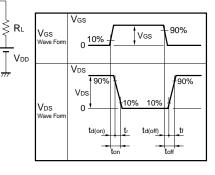
TEST CIRCUIT 3 GATE CHARGE



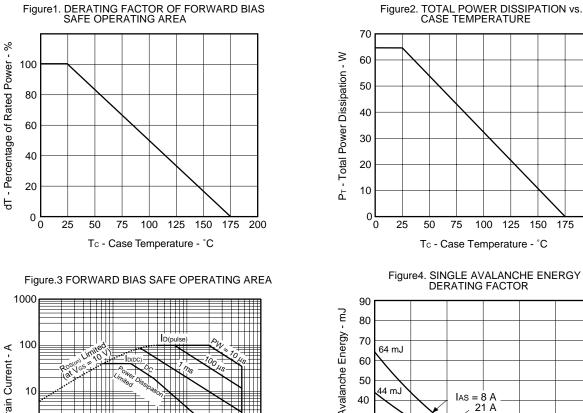
TEST CIRCUIT 2 SWITCHING TIME

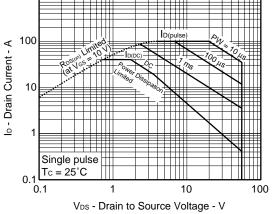
₩





TYPICAL CHARACTERISTICS ($T_A = 25^{\circ}C$)





175 200

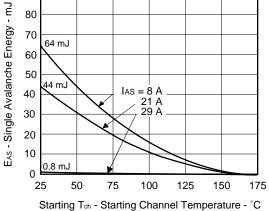


Figure5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

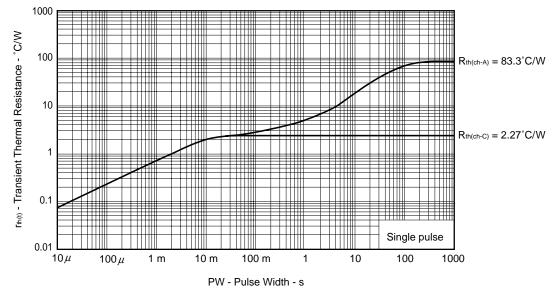
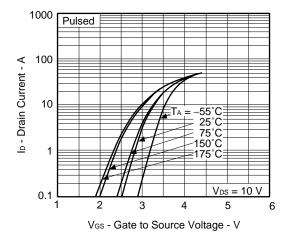
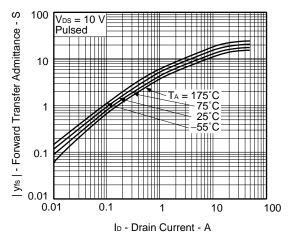
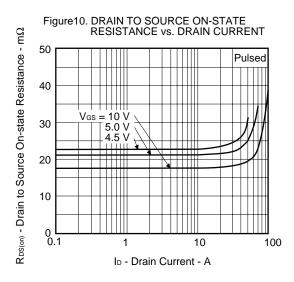


Figure6. FORWARD TRANSFER CHARACTERISTICS









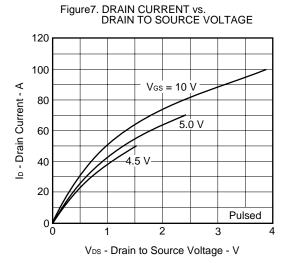


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

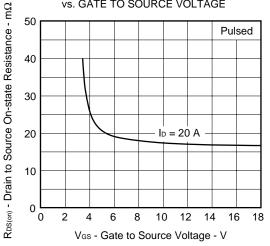
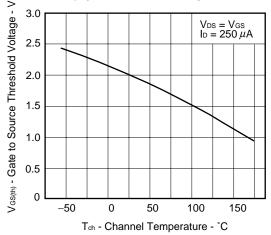
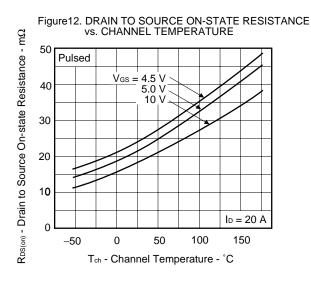
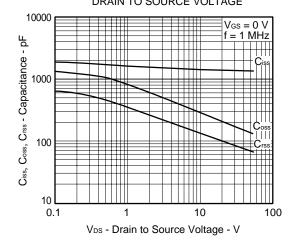


Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE

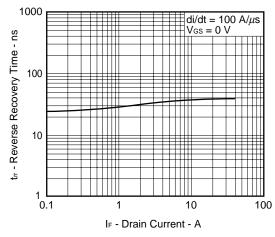












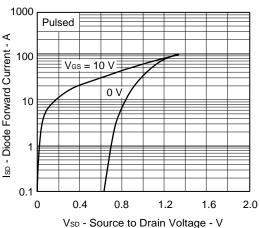
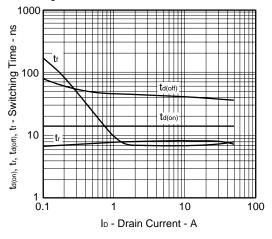
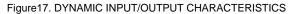


Figure15. SWITCHING CHARACTERISTICS





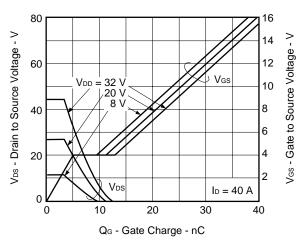
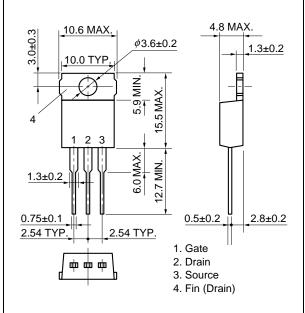
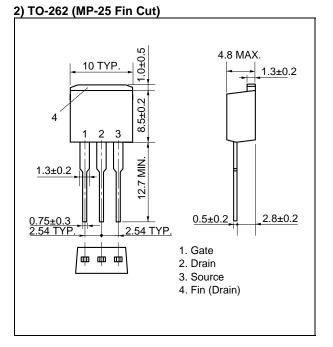


Figure 13. SOURCE TO DRAIN DIODE FORWARD VOLTAGE

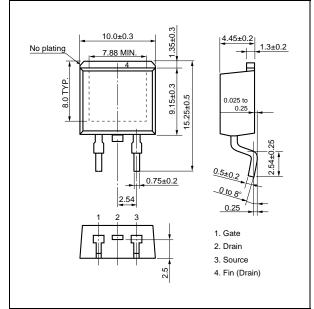
PACKAGE DRAWINGS (Unit: mm)

1) TO-220AB (MP-25)

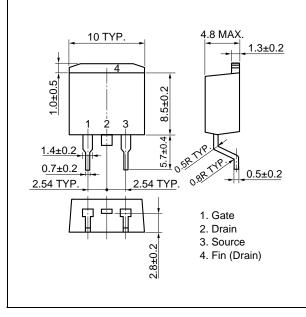




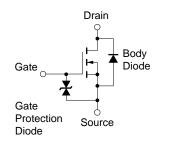
★ 4) TO-263 (MP-25ZK)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

[MEMO]

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